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Notice of References Cited	Application/Control No. 09/617,232	Applicant(s)/Patent Under Reexamination DRWIEGA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,590,867	07-2003	Ash et al.	370/236
	B	US-6,577,653	06-2003	Rochberger et al.	370/536
	C	US-6,563,793	05-2003	Golden et al.	370/236
	D	US-6,469,982	10-2002	Henrion et al.	370/230
	E	US-6,442,138	08-2002	Yin et al.	370/232
	F	US-6,404,735	06-2002	Beshai et al.	370/230
	G	US-6,377,546	04-2002	Guerin et al.	370/230
	H	US-6,353,616	03-2002	Elwalid et al.	370/443
	I	US-6,285,658	09-2001	Packer, Robert L.	370/230
	J	US-6,252,857	06-2001	Fendick et al.	370/254
	K	US-6,118,791	09-2000	Fichou et al.	370/468
	L	US-6,011,776	01-2000	Berthaud et al.	370/232
	M	US-5,933,425	08-1999	Iwata, Atsushi	370/351

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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